

Notice of References Cited	Application/Control No. 10/522,219		Applicant(s)/Patent Under Reexamination SALAUN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0053795	03-2003	Ando, Yuji	386/95
*	B	US-2003/0147561	08-2003	Faibish et al.	382/245
*	C	US-2003/0165320	09-2003	Ogawa et al.	386/52
*	D	US-2002/0122358	09-2002	Tada et al.	369/30.23
*	E	US-2002/0069288	06-2002	Rising et al.	709/231
*	F	US-2002/0071490	06-2002	Tsuboi, Eiji	375/240.15
*	G	US-2002/0018580	02-2002	Maeda, Mitsuru	382/100
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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